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SHEET 1 OF 1

Form PTO 1449 (Modified)	U.S. DEPARTMENT OF COMMERCE PATENT AND TRANSMENT OFFICE			ATTY DOCKET NO. 220212US2			SERIAL NO. 10/084,221			
LIST OF	REFER	RENCES CITED BY APPL	.ICANT	APPLICANT Kazuya OHUCHI						
				FILING DATE February 28, 2002			GROUP 2815			
U.S. PATENT DOCUMENTS										
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Examiner	Examiner JOSEPH NAVYEN Date Considered 2573023									
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